CD4029B Types

CMOS Presettable Up/Down Counter

Binary or BCD-Decade

High-Voltage Types (20-Volt Rating)

■ CD4029B consists of a four-stage binary or BCD-decade up/down counter with provisions for look-ahead carry in both counting modes. The inputs consist of a single CLOCK, CARRY-IN (CLOCK ENABLE), BINARY/DECADE, UP/DOWN, PRESET ENABLE, and four individual JAM signals. Q1, Q2, Q3, Q4 and a CARRY OUT signal are provided as outputs.

A high PRESET ENABLE signal allows information on the JAM INPUTS to preset the counter to any state asynchronously with the clock. A low on each JAM line, when the PRESET-ENABLE signal is high, resets the counter to its zero count. The counter is advanced one count at the positive transition of the clock when the CARRY-IN and PRESET ENABLE signals are low. Advancement is inhibited when the CARRY-IN or PRESET ENABLE signals are high. The CARRY-OUT signal is normally high and goes low when the counter reaches its maximum count in the UP mode or the minimum count in the DOWN mode provided the CARRY-IN signal is low. The CARRY-IN signal in the low state can thus be considered a CLOCK ENABLE. The CARRY-IN terminal must be connected to V_{SS} when not in use.

Binary counting is accomplished when the BINARY/DECADE input is high; the counter counts in the decade mode when the BINARY/DECADE input is low. The counter counts up when the UP/DOWN input is high, and down when the UP/DOWN input is low. Multiple packages can be connected in either a parallel-clocking or a ripple-clocking arrangement as shown in Fig. 17.

Parallel clocking provides synchronous control and hence faster response from all counting outputs. Ripple-clocking allows for longer clock input rise and fall times.

The CD4029B-series types are supplied in 16-lead hermetic dual-in-line ceramic packages (F3A suffix), 16-lead dual-in-line plastic packages (E suffix), 16-lead small-outline packages (M, M96, MT, and NSR suffixes), and 16-lead thin shrink small-outline packages (PW and PWR suffixes).

CD4029B Terminal Diagram
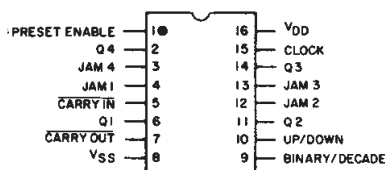
92CS-24472R1

Features:

■ Medium-speed operation . . . 8 MHz (typ.) @ C_L = 50 pF and $V_{DD} - V_{SS}$ = 10 V
■ Multi-package parallel clocking for synchronous high speed output response or ripple clocking for slow clock input rise and fall times
■ "Preset Enable" and individual "Jam" inputs provided
■ Binary or decade up/down counting
■ BCD outputs in decade mode
■ 100% tested for quiescent current at 20 V
■ 5-V, 10-V, and 15-V parametric ratings
■ Standardized, symmetrical output characteristics
■ Maximum input current of 1 μA at 18 V over full package-temperature range; 100 nA at 18 V and 25°C
■ Noise margin (over full package-temperature range)
   1 V at V_{DD} = 5 V
   2 V at V_{DD} = 10 V
   2.5 V at V_{DD} = 15 V
■ Meets all requirements of JEDEC Tentative Standard No. 13B, "Standard Specifications for Description of 'B' Series CMOS Devices"
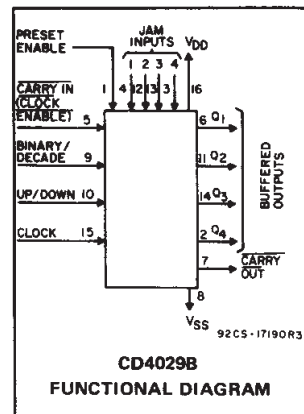
Applications:

■ Programmable binary and decade counting/frequency synthesizers-BCD output
■ Analog to digital and digital to analog conversion
■ Up/Down binary counting
■ Magnitude and sign generation
■ Up/Down decade counting
■ Difference counting

CD4029B
FUNCTIONAL DIAGRAM

92CS-17190R3

RECOMMENDED OPERATING CONDITIONS at T_A = 25°C, Except as Noted. For maximum reliability, nominal operating conditions should be selected so that operation is always within the following ranges:

CHARACTERISTIC	V_{DD} (V)	LIMITS		UNITS
		Min.	Max.	
Supply-Voltage Range (For T_A = Full Package-Temperature Range)	—	3	18	V
Setup Time t_{SU}: Carry-In	5	200	—	
	10	70	—	
	15	60	—	
U/D or B/D	5	340	—	
	10	140	—	
	15	100	—	ns
Clock Pulse Width, t_W	5	180	—	
	10	90	—	
	15	60	—	
Preset Enable Pulse Width, t_W	5	130	—	
	10	70	—	
	15	50	—	
Clock Input Frequency, f_{CL}	5	—	2	
	10	—	4	MHz
	15	—	5.5	
Clock Rise and Fall Time, t_rCL, t_fCL	5	—		
	10	—	15	μs
	15	—		

CD4029B Types

MAXIMUM RATINGS, *Absolute-Maximum Values:*

DC SUPPLY-VOLTAGE RANGE, (V_{DD})
  Voltages referenced to V_{SS} Terminal) .... −0.5V to +20V
INPUT VOLTAGE RANGE, ALL INPUTS .... −0.5V to V_{DD} +0.5V
DC INPUT CURRENT, ANY ONE INPUT .... ±10mA
POWER DISSIPATION PER PACKAGE (P_D):
  For T_A = −55°C to +100°C 500mW
  For T_A = +100°C to +125°C .... Derate Linearity at 12mW/°C to 200mW
DEVICE DISSIPATION PER OUTPUT TRANSISTOR
  FOR T_A = FULL PACKAGE-TEMPERATURE RANGE (All Package Types) 100mW
OPERATING-TEMPERATURE RANGE (T_A) .... −55°C to +125°C
STORAGE TEMPERATURE RANGE (T_{stg}) .... −65°C to +150°C
LEAD TEMPERATURE (DURING SOLDERING):
  At distance 1/16 ± 1/32 inch (1.59 ± 0.79mm) from case for 10s max .... +265°C
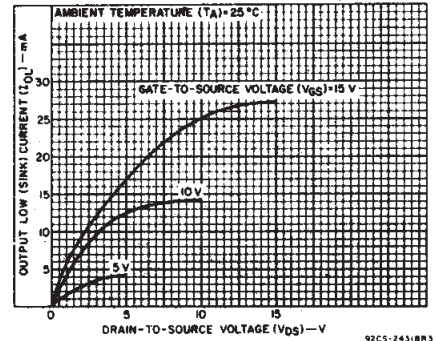

Fig. 1 — *Typical output low (sink) current characteristics.*
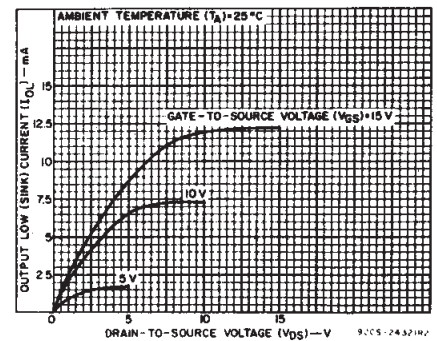
Fig. 2 — *Minimum output low (sink) current characteristics.*

STATIC ELECTRICAL CHARACTERISTICS

CHARAC-TERISTIC	CONDITIONS			LIMITS AT INDICATED TEMPERATURES (°C)							UNITS
	V_O (V)	V_{IN} (V)	V_{DD} (V)	−55	−40	+85	+125	+25 Min.	+25 Typ.	+25 Max.	
Quiescent Device Current, I_{DD} Max.	−	0,5	5	5	5	150	150	−	0.04	5	μA
	−	0,10	10	10	10	300	300	−	0.04	10	
	−	0,15	15	20	20	600	600	−	0.04	20	
	−	0,20	20	100	100	3000	3000	−	0.08	100	
Output Low (Sink) Current I_{OL} Min.	0.4	0,5	5	0.64	0.61	0.42	0.36	0.51	1	−	mA
	0.5	0,10	10	1.6	1.5	1.1	0.9	1.3	2.6	−	
	1.5	0,15	15	4.2	4	2.8	2.4	3.4	6.8	−	
Output High (Source) Current, I_{OH} Min.	4.6	0,5	5	−0.64	−0.61	−0.42	−0.36	−0.51	−1	−	
	2.5	0,5	5	−2	−1.8	−1.3	−1.15	−1.6	−3.2	−	
	9.5	0,10	10	−1.6	−1.5	−1.1	−0.9	−1.3	−2.6	−	
	13.5	0,15	15	−4.2	−4	−2.8	−2.4	−3.4	−6.8	−	
Output Voltage: Low-Level, V_{OL} Max.	−	0,5	5	0.05				−	0	0.05	V
	−	0,10	10	0.05				−	0	0.05	
	−	0,15	15	0.05				−	0	0.05	
Output Voltage: High-Level, V_{OH} Min.	−	0,5	5	4.95				4.95	5	−	
	−	0,10	10	9.95				9.95	10	−	
	−	0,15	15	14.95				14.95	15	−	
Input Low Voltage V_{IL} Max.	0.5,4.5	−	5	1.5				−	−	1.5	V
	1,9	−	10	3				−	−	3	
	1.5,13.5	−	15	4				−	−	4	
Input High Voltage, V_{IH} Min.	0.5,4.5	−	5	3.5				3.5	−	−	
	1,9	−	10	7				7	−	−	
	1.5,13.5	−	15	11				11	−	−	
Input Current I_{IN} Max.	−	0,18	18	±0.1	±0.1	±1	±1	−	$±10^{-5}$	±0.1	μA

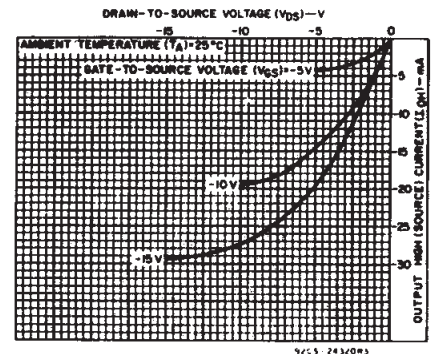
Fig. 3 − *Typical output high (source) current characteristics.*
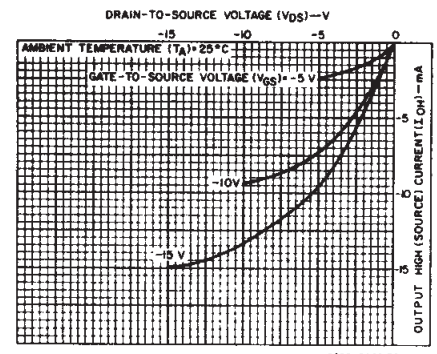
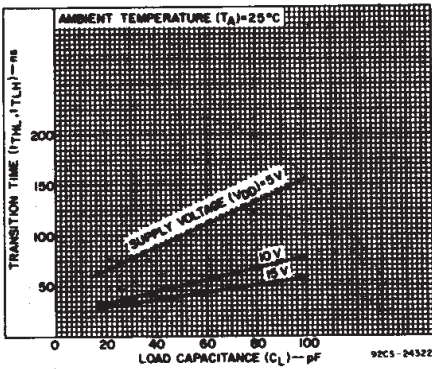Fig. 4 — *Minimum output high (source) current characteristics.*

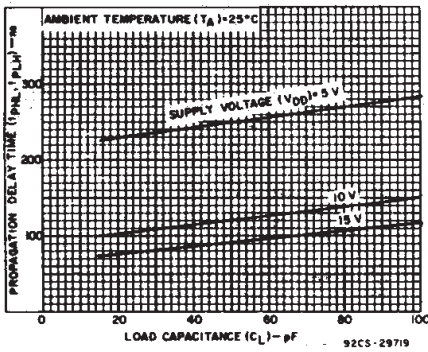Fig. 5 — Typical transition time as a function of load capacitance.

Fig. 6 — Typical propagation delay times as a function of load capacitance (Q output).
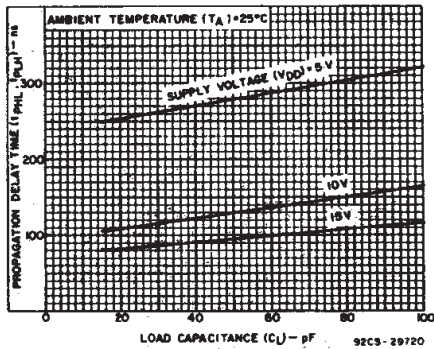
Fig. 7 — Typical propagation delay time as a function of load capacitance (carry output).
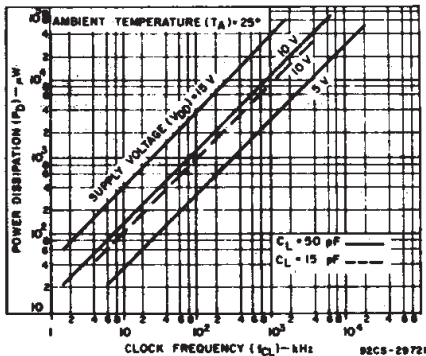
Fig. 8 — Typical power dissipation as a function of frequency.

92CL-28675R1

Fig. 9 — Logic diagram.

*ALL INPUTS ARE PROTECTED BY CMOS INPUT PROTECTION NETWORK
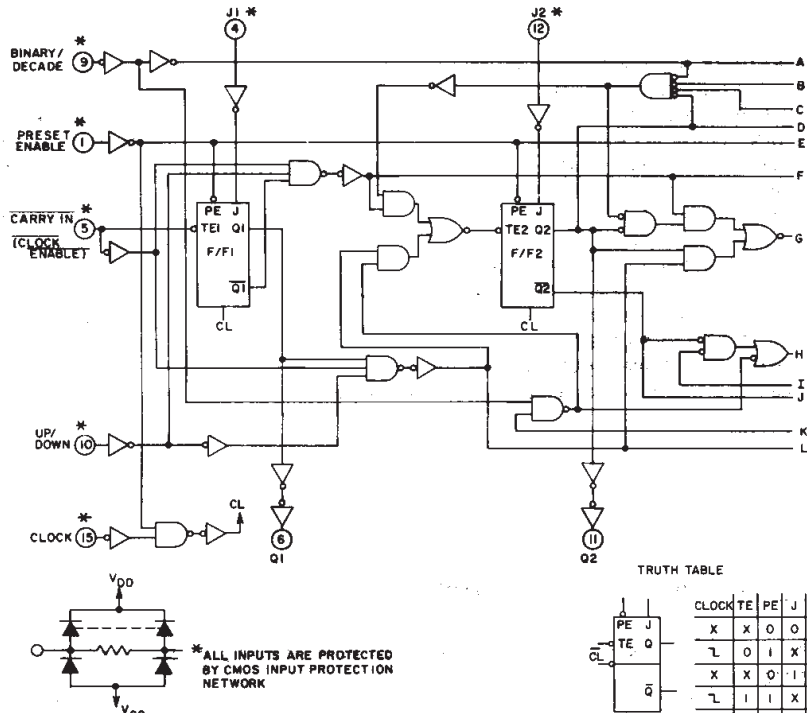
TRUTH TABLE

CLOCK	TE	PE	J	Q	Q̄
X	X	0	0	0	1
⅃	0	1	X	Q̄	Q
X	X	0	1	1	0
⅃	1	1	X	Q	Q̄ NC
⌐	X	1	X	Q	Q̄ NC

X-DON'T CARE
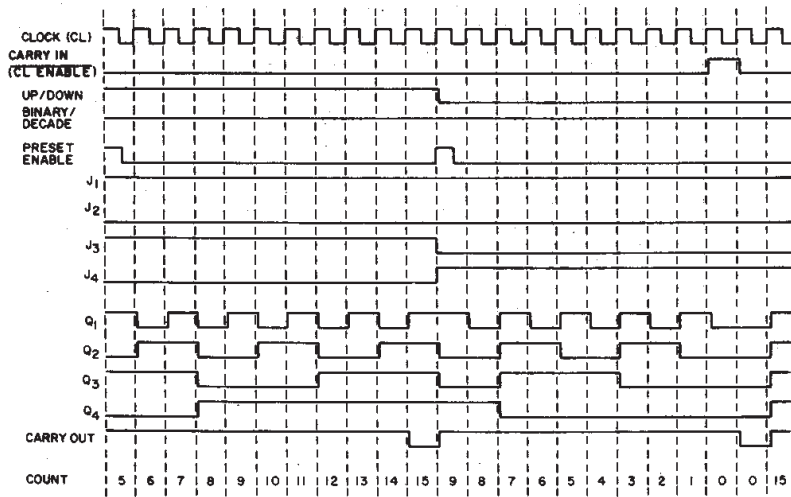
Fig. 10 — Timing diagram-binary mode.

92CM-17192R2

3-86
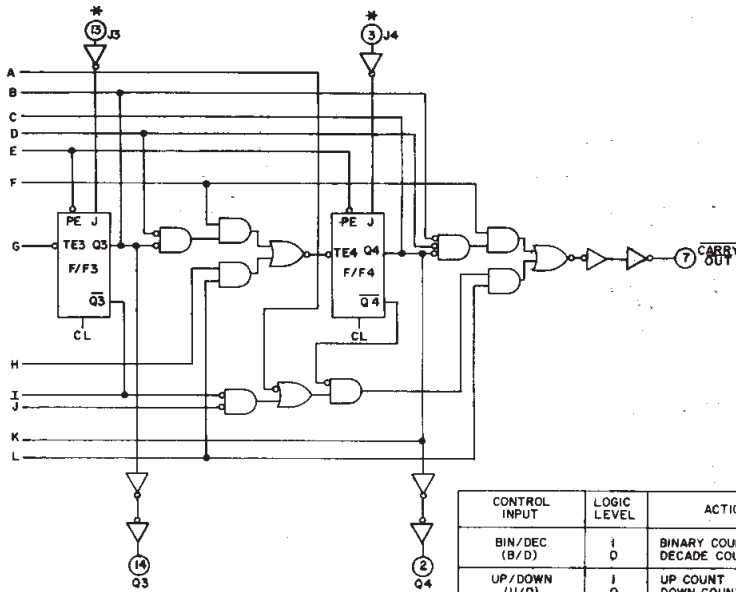
CONTROL INPUT	LOGIC LEVEL	ACTION
BIN/DEC. (B/D)	1	BINARY COUNT
	0	DECADE COUNT
UP/DOWN (U/D)	1	UP COUNT
	0	DOWN COUNT
PRESET ENABLE (PE)	1	JAM IN
	0	NO JAM
CARRY IN (CI) (CLOCK ENABLE)	1	NO COUNTER ADVANCE AT POS. CLOCK TRANSITION
	0	ADVANCE COUNTER AT POS. CLOCK TRANSITION

Fig. 9 — Logic diagram (cont'd).
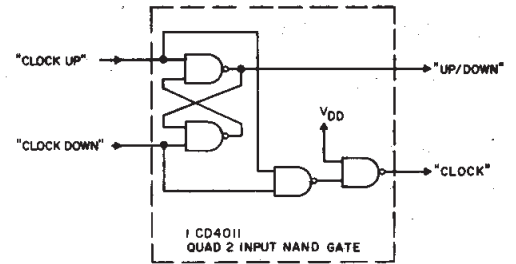
92CS-17195R2

Fig. 11 — Conversion of clock up, clock down input signals to clock and up/down input signals.

The CD4029B CLOCK and UP/DOWN inputs are used directly in most applications. In applications where CLOCK UP and CLOCK DOWN inputs are provided, conversion to the CD4029B CLOCK and UP/DOWN inputs can easily be realized by use of the circuit in Fig. 11.

CD4029B changes count on positive transitions of CLOCK UP or CLOCK DOWN inputs. For the gate configuration shown below, when counting up the CLOCK DOWN input must be maintained high and conversely when counting down the CLOCK UP input must be maintained high.
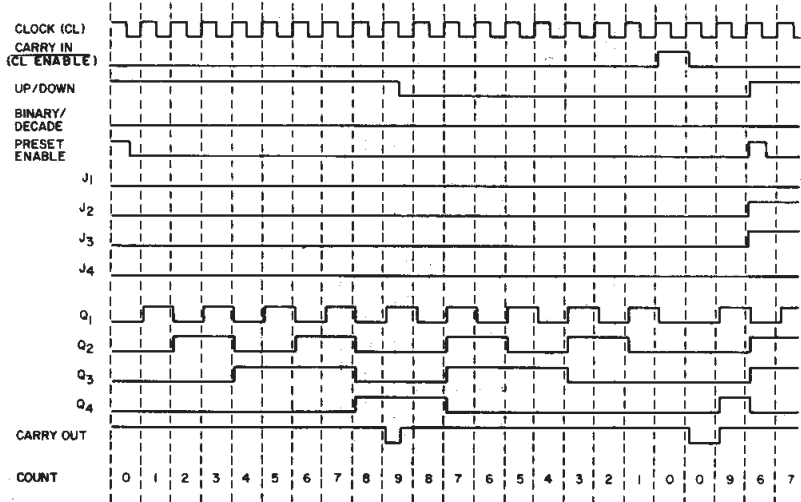
92CM-17193R3

Fig. 12 — Timing diagram-decade mode.

DYNAMIC ELECTRICAL CHARACTERISTICS at T_A = 25°C, Input t_r, t_f = 20 ns, C_L = 50 pF, R_L = 200 kΩ

CHARACTERISTIC	TEST CONDITIONS V_{DD} (V)	LIMITS Min.	LIMITS Typ.	LIMITS Max.	UNITS
Clocked Operation					
Propagation Delay Time: t_{PHL}, t_{PLH} Q Output	5	—	250	500	
	10	—	120	240	
	15	—	90	180	
Carry Output	5	—	280	560	
	10	—	130	260	
	15	—	95	190	ns
Transition Time: t_{THL}, t_{TLH} Q Outputs, Carry Output	5	—	100	200	
	10	—	50	100	
	15	—	40	80	
Minimum Clock Pulse Width, t_W	5	—	90	180	
	10	—	45	90	
	15	—	30	60	
Clock Rise & Fall Time, t_rCL, t_fCL **	5	—	—	15	
	10	—	—	15	μs
	15	—	—	15	
Minimum Setup Times, t_S * B/D or U/D	5	—	170	340	
	10	—	70	140	ns
	15	—	50	100	
Maximum Clock Input Frequency, f_{CL}	5	2	4	—	
	10	4	8	—	MHz
	15	5.5	11	—	
Input Capacitance, C_{IN}	Any Input	—	5	7.5	pF
Preset Enable					
Propagation Delay Time: t_{PHL}, t_{PLH} Q Outputs	5	—	235	470	
	10	—	100	200	
	15	—	80	160	
Carry Output	5	—	320	640	
	10	—	145	290	
	15	—	105	210	ns
Minimum Preset Enable Pulse Width, t_W	5	—	65	130	
	10	—	35	70	
	15	—	25	50	
Minimum Preset Enable Removal Time, t_{rem} *	5	—	100	200	
	10	—	55	110	
	15	—	40	80	
Carry Input					
Propagation Delay Time: t_{PHL}, t_{PLH} Carry Output	5	—	170	340	
	10	—	70	140	ns
	15	—	50	100	
Min. HOLD Time t_H *** Carry In	5	—	25	50	ns
	10	—	15	30	
	15	—	12	25	
Min Set-Up Time t_s *** Carry In	5	—	100	200	ns
	10	—	35	70	
	15	—	30	60	

* From Up/Down, Binary/Decode, Carry In, or Preset Enable Control Inputs to Clock Edge.

** If more than one unit is cascaded in the parallel clocked application, t_rCL should be made less than or equal to the sum of the fixed propagation delay at 15 pF and the transition time of the carry output driving stage for the estimated capacitive load. This measurement was made with a decoupling capacitor (>1 μF) between V_{DD} and V_{SS}.   ***From Carry In to Clock Edge.
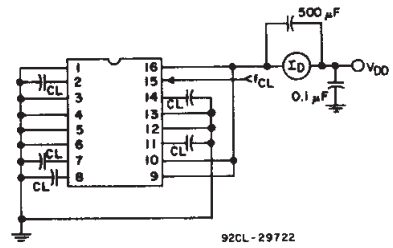
Fig. 13 — Power dissipation test circuit.
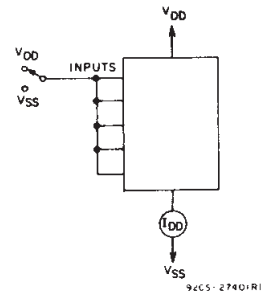
Fig. 14 — Quiescent-device current test circuit.
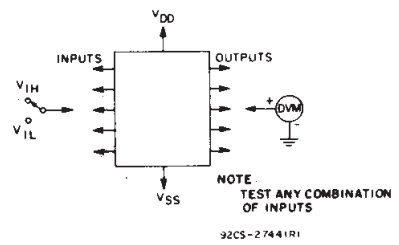
Fig. 15 — Input voltage test circuit.
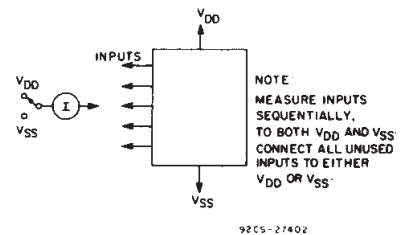
Fig. 16 — Input current test circuit.

"PARALLEL CLOCKING"
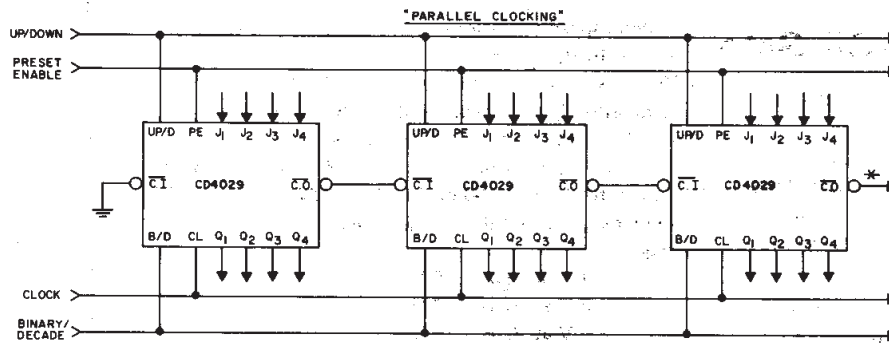
* CARRY OUT lines at the 2nd, 3rd, etc., stages may have a negative-going glitch
pulse resulting from differential delays of different CD4029B IC's. These negative-
going glitches do not affect proper CD4029B operation. However, if the CARRY OUT
signals are used to trigger other edge-sensitive logic devices, such as FF's or counters,
the CARRY OUT signals should be gated with the clock signal using a 2-input OR gate
such as CD4071B.
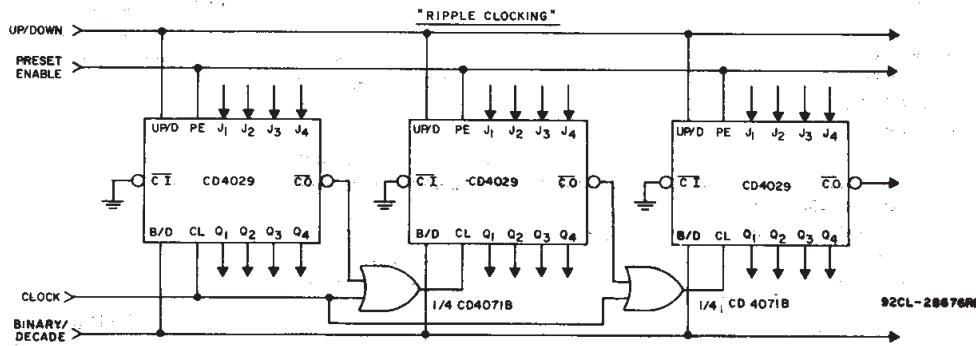
"RIPPLE CLOCKING"

Ripple Clocking Mode:
The Up/Down control can be changed at any count. The only restriction on changing
the Up/Down control is that the clock input to the first counting stage must be high.

For cascading counters operating in a fixed up-count or down-count mode, the OR
gates are not required between stages, and CO is connected directly to the CL input of
the next stage with CI grounded.

Fig. 17 — Cascading counter packages.
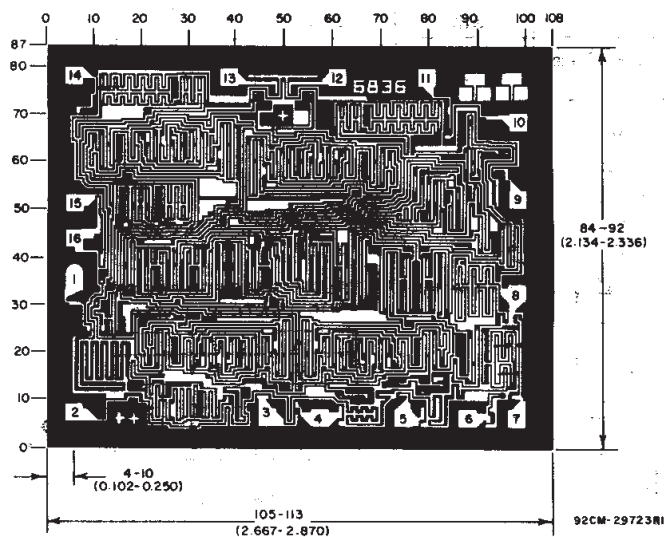
Chip dimensions and pad layout for CD4029B

Dimensions in parentheses are in millimeters and
are derived from the basic inch dimensions as in-
dicated. Grid graduations are in mils (10^{-3} inch).

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead/Ball Finish (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
8101602EA	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	8101602EA CD4029BF3A	Samples
CD4029BE	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4029BE	Samples
CD4029BEE4	ACTIVE	PDIP	N	16	25	Pb-Free (RoHS)	CU NIPDAU	N / A for Pkg Type	-55 to 125	CD4029BE	Samples
CD4029BF	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	CD4029BF	Samples
CD4029BF3A	ACTIVE	CDIP	J	16	1	TBD	A42	N / A for Pkg Type	-55 to 125	8101602EA CD4029BF3A	Samples
CD4029BM	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4029BM	Samples
CD4029BM96	ACTIVE	SOIC	D	16	2500	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4029BM	Samples
CD4029BMG4	ACTIVE	SOIC	D	16	40	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4029BM	Samples
CD4029BNSR	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4029B	Samples
CD4029BNSRE4	ACTIVE	SO	NS	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CD4029B	Samples
CD4029BPWR	ACTIVE	TSSOP	PW	16	2000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-1-260C-UNLIM	-55 to 125	CM029B	Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details.
TBD: The Pb-Free/Green conversion plan has not been defined.
Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.
Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead/Ball Finish - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead/Ball Finish values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF CD4029B, CD4029B-MIL :

• Catalog: CD4029B

• Military: CD4029B-MIL

NOTE: Qualified Version Definitions:

  • Catalog - TI's standard catalog product

  • Military - QML certified for Military and Defense Applications

PACKAGE MATERIALS INFORMATION

TAPE AND REEL INFORMATION

REEL DIMENSIONS

TAPE DIMENSIONS

A0	Dimension designed to accommodate the component width
B0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

TAPE AND REEL INFORMATION

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
CD4029BM96	SOIC	D	16	2500	330.0	16.4	6.5	10.3	2.1	8.0	16.0	Q1
CD4029BNSR	SO	NS	16	2000	330.0	16.4	8.2	10.5	2.5	12.0	16.0	Q1
CD4029BPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

TEXAS INSTRUMENTS

PACKAGE MATERIALS INFORMATION

TAPE AND REEL BOX DIMENSIONS

*All dimensions are nominal

Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
CD4029BM96	SOIC	D	16	2500	333.2	345.9	28.6
CD4029BNSR	SO	NS	16	2000	367.0	367.0	38.0
CD4029BPWR	TSSOP	PW	16	2000	367.0	367.0	35.0

PINS ∗∗ DIM	14	16	18	20
A	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC	0.300 (7,62) BSC
B MAX	0.785 (19,94)	.840 (21,34)	0.960 (24,38)	1.060 (26,92)
B MIN	—	—	—	—
C MAX	0.300 (7,62)	0.300 (7,62)	0.310 (7,87)	0.300 (7,62)
C MIN	0.245 (6,22)	0.245 (6,22)	0.220 (5,59)	0.245 (6,22)

B

14   8

0.065 (1,65)
0.045 (1,14)

C

1   7

0.005 (0,13) MIN

0.060 (1,52)
0.015 (0,38)

0.200 (5,08) MAX

Seating Plane

0.130 (3,30) MIN

0.026 (0,66)
0.014 (0,36)

0.100 (2,54)

A

0°−15°

0.014 (0,36)
0.008 (0,20)

4040083/F 03/03

NOTES: A. All linear dimensions are in inches (millimeters).
          B. This drawing is subject to change without notice.
          C. This package is hermetically sealed with a ceramic lid using glass frit.
          D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
          E. Falls within MIL STD 1835 GDIP1−T14, GDIP1−T16, GDIP1−T18 and GDIP1−T20.

N (R−PDIP−T**)

16 PINS SHOWN

PLASTIC DUAL−IN−LINE PACKAGE

DIM \ PINS **	14	16	18	20
A MAX	0.775 (19,69)	0.775 (19,69)	0.920 (23,37)	1.060 (26,92)
A MIN	0.745 (18,92)	0.745 (18,92)	0.850 (21,59)	0.940 (23,88)
MS−001 VARIATION	AA	BB	AC	AD

A

16   9

0.260 (6,60)
0.240 (6,10)

1   8

0.070 (1,78)
0.045 (1,14) △D

0.045 (1,14)
0.030 (0,76) △D

0.020 (0,51) MIN

0.325 (8,26)
0.300 (7,62)

0.015 (0,38)

Gauge Plane

0.200 (5,08) MAX

Seating Plane

0.010 (0,25) NOM

0.125 (3,18) MIN

0.100 (2,54)

0.021 (0,53)
0.015 (0,38)

⊕ 0.010 (0,25) Ⓜ

0.430 (10,92) MAX

14/18 Pin Only
20 Pin vendor option △D

4040049/E 12/2002
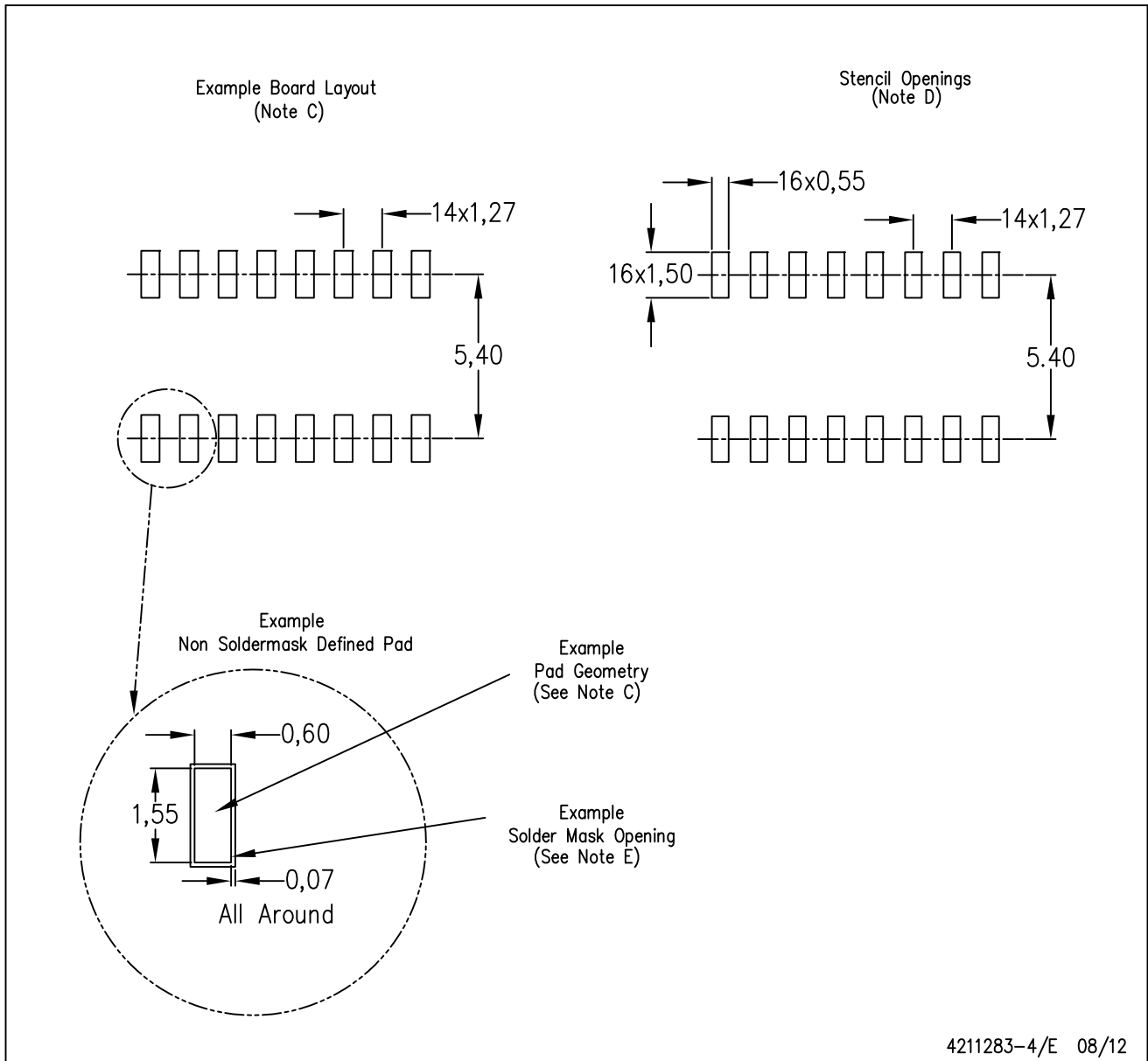
NOTES: A. All linear dimensions are in inches (millimeters).
         B. This drawing is subject to change without notice.
      △C Falls within JEDEC MS−001, except 18 and 20 pin minimum body length (Dim A).
      △D The 20 pin end lead shoulder width is a vendor option, either half or full width.

D (R−PDSO−G16)   PLASTIC SMALL OUTLINE

0.394 (10,00)
0.386 (9,80)
⟨C⟩

16   9

0.244 (6,20)
0.228 (5,80)

0.157 (4,00)
0.150 (3,80) ⟨D⟩

1   8

Pin 1
Index Area

0.050 (1,27)

0.020 (0,51)
0.012 (0,31)

⊕ 0.010 (0,25) Ⓜ

0.069 (1,75) Max

0.010 (0,25)
0.004 (0,10)

0.010 (0,25)
0.005 (0,13)

0.004 (0,10)

Gauge Plane

Seating Plane

0.010 (0,25)   0°−8°

0.050 (1,27)
0.016 (0,40)

4040047−6/M   06/11

NOTES: A. All linear dimensions are in inches (millimeters).
         B. This drawing is subject to change without notice.
         ⟨C⟩ Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall
             not exceed 0.006 (0,15) each side.
         ⟨D⟩ Body width does not include interlead flash. Interlead flash shall not exceed 0.017 (0,43) each side.
         E. Reference JEDEC MS−012 variation AC.

TEXAS INSTRUMENTS
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D (R-PDSO-G16)   PLASTIC SMALL OUTLINE

Example Board Layout
(Note C)

Stencil Openings
(Note D)

14x1,27

16x0,55

14x1,27

16x1,50

5,40

5.40

Example
Non Soldermask Defined Pad

Example
Pad Geometry
(See Note C)

0,60

1,55

Example
Solder Mask Opening
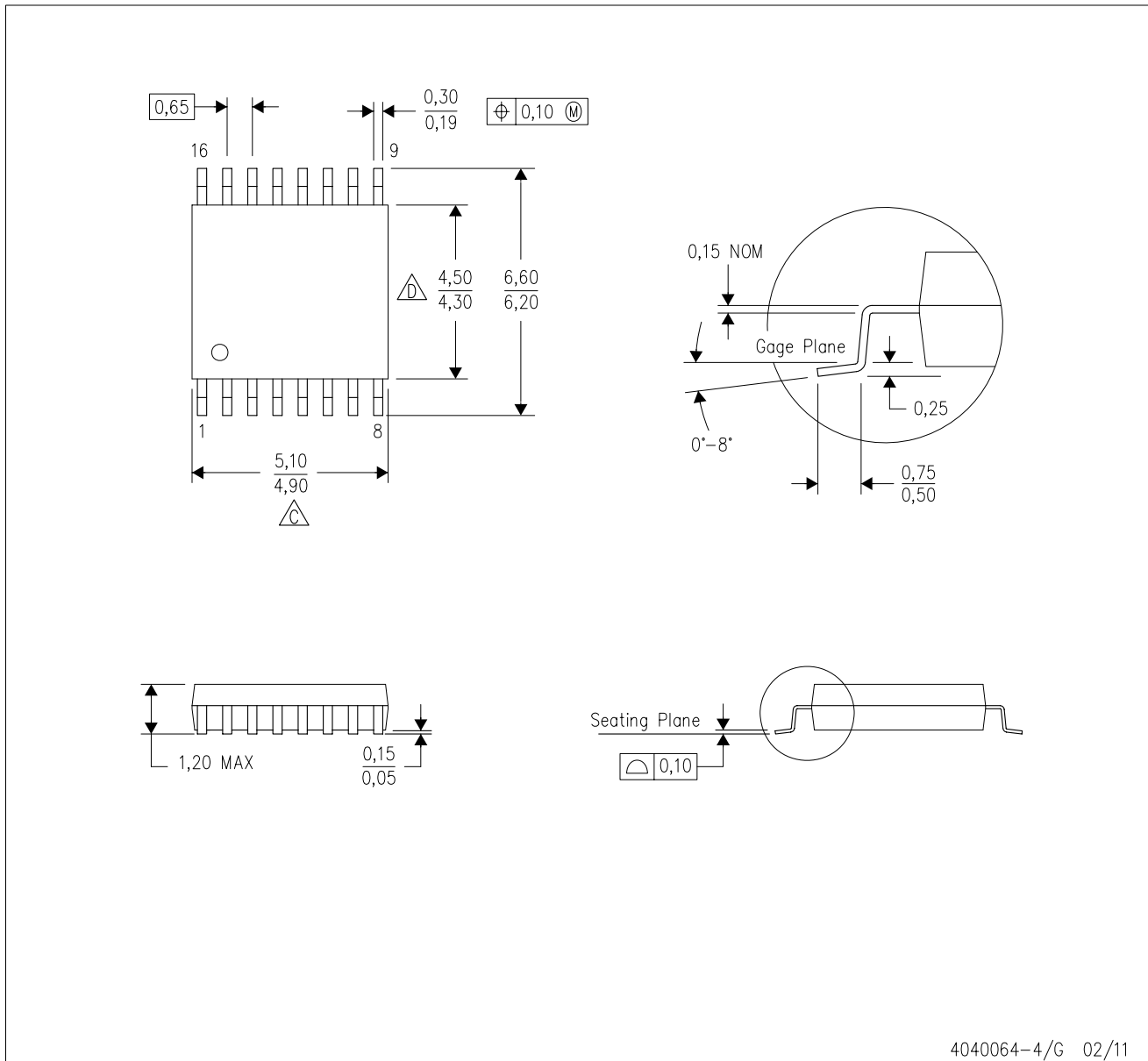(See Note E)

0,07

All Around

4211283-4/E 08/12

NOTES: A. All linear dimensions are in millimeters.
         B. This drawing is subject to change without notice.
         C. Publication IPC-7351 is recommended for alternate designs.
         D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should
             contact their board assembly site for stencil design recommendations. Refer to IPC-7525 for other stencil recommendations.
         E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.
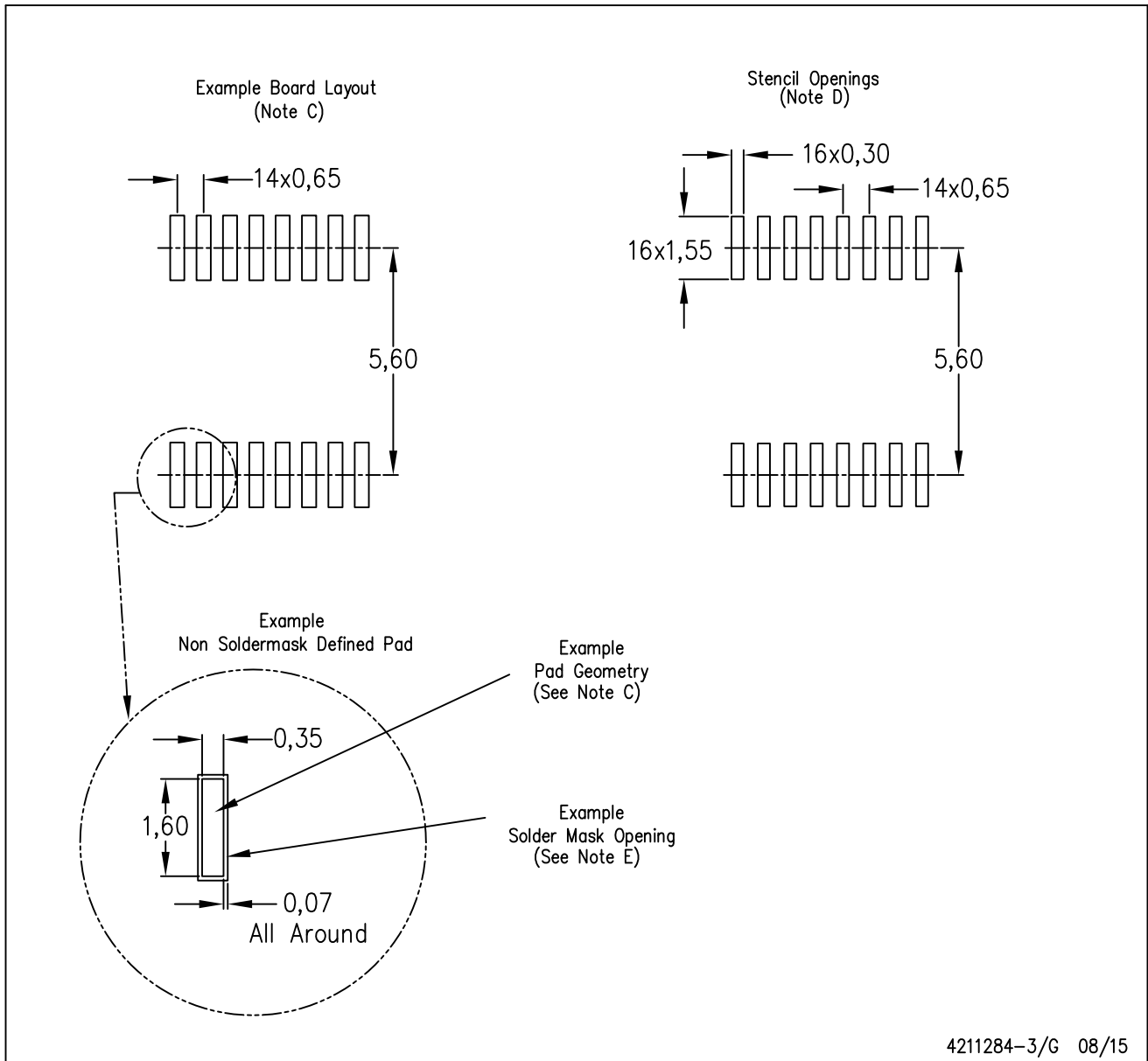
PW (R−PDSO−G16) PLASTIC SMALL OUTLINE

0,65

0,30
0,19

⊕ | 0,10 Ⓜ

16   9

D△   4,50
     4,30

6,60
6,20

1   8

5,10
4,90

△C

0,15 NOM

Gage Plane

0,25

0°−8°

0,75
0,50

1,20 MAX

0,15
0,05

Seating Plane

⌒ | 0,10

4040064−4/G 02/11

NOTES: A. All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M−1994.
        B. This drawing is subject to change without notice.
        △C Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall
            not exceed 0,15 each side.
        △D Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
        E. Falls within JEDEC MO−153

PW (R−PDSO−G16)   PLASTIC SMALL OUTLINE

Example Board Layout
(Note C)

14x0,65

5,60

Stencil Openings
(Note D)

16x0,30

14x0,65

16x1,55

5,60

Example
Non Soldermask Defined Pad

Example
Pad Geometry
(See Note C)

0,35

1,60

0,07
All Around

Example
Solder Mask Opening
(See Note E)

4211284−3/G   08/15

NOTES: A. All linear dimensions are in millimeters.
          B. This drawing is subject to change without notice.
          C. Publication IPC−7351 is recommended for alternate designs.
          D. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should
              contact their board assembly site for stencil design recommendations. Refer to IPC−7525 for other stencil recommendations.
          E. Customers should contact their board fabrication site for solder mask tolerances between and around signal pads.

NS (R-PDSO-G)**   PLASTIC SMALL-OUTLINE PACKAGE

14-PINS SHOWN

DIM / PINS **	14	16	20	24
A MAX	10,50	10,50	12,90	15,30
A MIN	9,90	9,90	12,30	14,70

4040062/C 03/03

NOTES: A.   All linear dimensions are in millimeters.
         B.   This drawing is subject to change without notice.
         C.   Body dimensions do not include mold flash or protrusion, not to exceed 0,15.

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